





200V N-CHANNEL ENHANCEMENT MODE MOSFET

Product Summary

| V _{(BR)DSS} | R _{DS(on)} | I _D T _A = 25°C |
|----------------------|--------------------------------|---|
| 200V | 750mΩ @ Vgs = 10V | 2.3A |
| | $780\text{m}\Omega$ @ Vgs = 5V | 2.3A |

Description and Applications

This MOSFET features low on-resistance, fast switching and a high avalanche withstand capability, making it ideal for high efficiency power management applications.

- · SLIC line drivers for VoIP applications
- · Transformer driving switch
- · Power management functions
- Motor control
- Uninterrupted power supply

Features and Benefits

- 100% Unclamped Inductive Switch (UIS) test in production
- High avalanche energy pulse withstand capability
- Low gate drive voltage (Logic level capable)
- Low input capacitance
- · Low on-resistance
- · Fast switching speed
- "Green" Component and RoHS compliant (Note 1)
- Qualified to AEC-Q101 Standards for High Reliability

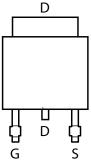
Mechanical Data

- Case: TO252-3L
- Case Material: Molded Plastic "Green" Molding Compound, UL Flammability Classification Rating 94V-0 (Note 1)
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminal Connections: See Diagram
- Terminals: Matte Tin Finish annealed over Copper leadframe.
 Solderable per MIL-STD-202, Method 208
- Weight: 0.33 grams (approximate)

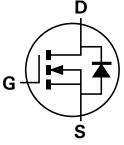




Top View



Pin Out - Top View



Equivalent Circuit

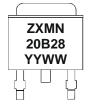
Ordering Information (Note 1)

| Product | Marking | Reel size (inches) | Tape width (mm) | Quantity per reel | |
|--------------|-----------|--------------------|-----------------|-------------------|--|
| ZXMN20B28KTC | See below | 13 | 16 | 2,500 | |

Note:

1. Diodes, Inc. defines "Green" products as those which are Eu RoHS compliant and contain no halogens or antimony compounds; further information about Diodes Inc.'s "Green" Policy can be found on our website. For packaging details, go to our website.

Marking Information



ZXMN = Product Type Marking Code, Line 1 20B28 = Product Type Marking Code, Line 2 YYWW = Date Code Marking YY = Year (ex: 09 = 2009) WW = Week (01-52)





Maximum Ratings @T_A = 25°C unless otherwise specified

| C | haracteristic | | Symbol | Value | Unit | |
|---|-----------------------|--|-----------------|-------------------|------|--|
| Drain-Source voltage | | | V_{DSS} | 200 | V | |
| Gate-Source voltage | | | V _{GS} | ±20 | V | |
| Single Pulsed Avalanche Ene | ergy | (Note 7) | E _{AS} | 73 | mJ | |
| Single Pulsed Avalanche Cui | rrent | (Note 7) | I _{AS} | 5.5 | A | |
| Repetitive Avalanche Energy (N | | (Note 4) | E _{AR} | 4.5 | mJ | |
| Repetitive Avalanche Current (Note 4) | | (Note 4) | I _{AR} | 5.5 | А | |
| Continuous Drain current | V _{GS} = 10V | (Note 3) T _A = 70°C (Note 3) (Note 2) | ID | 2.3 1.8 1.5 | А | |
| Pulsed Drain current V _{GS} = 10V (Note 4) | | (Note 4) | I _{DM} | 17.3 | Α | |
| Continuous Source current (Body diode) | | (Note 2) | I _S | 5.7 | Α | |
| Pulsed Source current (Body diode) | | (Note 4) | I _{SM} | 17.3 | Α | |

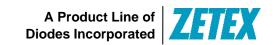
Thermal Characteristics

| Characteristic | Symbol | Value | Unit | | |
|---|----------|----------------------|--------------|------------|--|
| | (Note 2) | | 4.3 34.4 | | |
| Power dissipation Linear derating factor | (Note 3) | P _D | 10.2 76.0 | W mW/°C | |
| | (Note 6) | | 2.2 17.4 | | |
| | (Note 2) | | 29.1 | | |
| Thermal Resistance, Junction to Ambient | (Note 3) | $R_{	heta JA}$ | 12.3 | °C/W | |
| | (Note 6) | Ť | 57.3 | | |
| Thermal Resistance, Junction to Lead | (Note 5) | $R_{	heta JL}$ | 1.15 | °C/W | |
| Operating and storage temperature range | | TJ, T _{STG} | -55 to 150 | °C | |

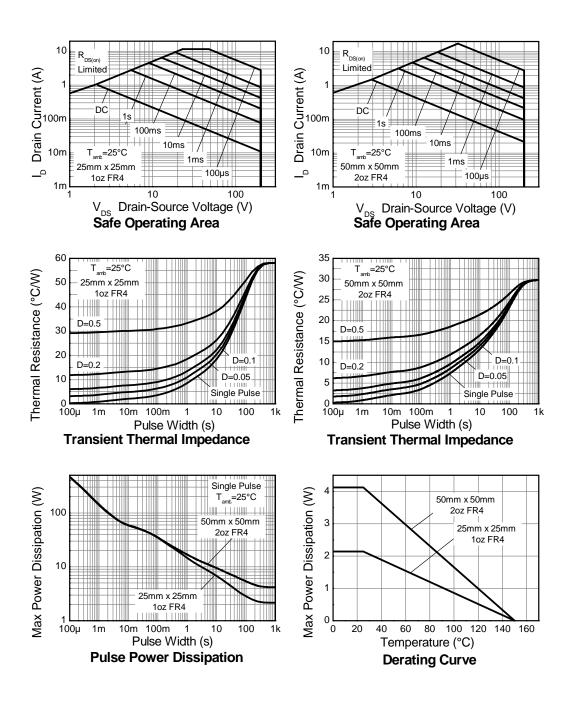
Notes:

- 2. For a device surface mounted on 50mm x 50mm x 1.6mm FR4 PCB with high coverage of single sided 2oz copper, in still air conditions; the device is measured when operating in a steady-state condition.
- 3. Same as note 2, except the device is measured at $t \le 10$ sec.
- 4. Same as note 2, except the device is operating in a repetitive state with pulse width and duty cycle limited by maximum junction temperature.
- 5. Thermal resistance from junction to solder-point (at the end of the drain lead).
- 6. For a device surface mounted on 25mm x 1.6mm FR4 PCB with the high coverage single sided 1oz copper, in still air conditions; the device is measured when operating in a steady-state condition.
- 7. UIS in production with L = 4.83mH, IAS = 5.5A, RG = 25 Ω , V_{DD} = 100V, starting TJ = 25 $^{\circ}$ C.

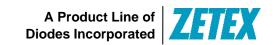




Thermal Characteristics







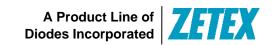
Electrical Characteristics @T_A = 25°C unless otherwise specified

| Characteristic | Symbol | Min | Тур | Max | Unit | Test Condition |
|--|----------------------|-----|-------|-------|------|--|
| OFF CHARACTERISTICS | | | | | | |
| Drain-Source Breakdown Voltage | BV _{DSS} | 200 | _ | _ | V | $I_D = 250 \mu A, V_{GS} = 0 V$ |
| Zero Gate Voltage Drain Current | I _{DSS} | _ | _ | 500 | nA | V _{DS} = 200V, V _{GS} = 0V |
| Gate-Source Leakage | I _{GSS} | _ | _ | ±100 | nA | $V_{GS} = \pm 20V, V_{DS} = 0V$ |
| ON CHARACTERISTICS | | | | | | |
| Gate Threshold Voltage | $V_{GS(th)}$ | 1 | 1.6 | 2.5 | V | $I_D=250\mu A,V_{DS}=V_{GS}$ |
| Static Drain Course On Registeres (Note 9) | 0 | | 0.650 | 0.750 | 0 | $V_{GS} = 10V, I_D = 2.75A$ |
| Static Drain-Source On-Resistance (Note 8) | R _{DS (ON)} | _ | 0.670 | 0.780 | Ω | V _{GS} = 5V, I _D = 2.75A |
| Forward Transconductance (Notes 8 & 9) | g _{fs} | _ | 6.13 | _ | S | $V_{DS} = 30V, I_D = 2.75A$ |
| Diode Forward Voltage (Note 8) | V _{SD} | _ | 0.860 | 0.950 | V | $I_S = 5.5A, V_{GS} = 0V$ |
| Reverse recovery time (Note 9) | t _{rr} | _ | 177 | _ | ns | $I_S = 6.5A, V_{GS} = 0V,$ |
| Reverse recovery charge (Note 9) | | _ | 1.4 | _ | μС | di/dt = 100A/μs |
| DYNAMIC CHARACTERISTICS (Note 9) | | | | | | |
| Input Capacitance | C _{iss} | _ | 358 | _ | pF | V 05V V 0V |
| Output Capacitance | Coss | _ | 50 | _ | pF | $V_{DS} = 25V, V_{GS} = 0V$ f = 1MHz |
| Reverse Transfer Capacitance | Crss | _ | 6.1 | _ | pF | 1 - 11011 12 |
| Total Gate Charge | Qg | _ | 8.1 | _ | nC | 1001/1/ 51/ |
| Gate-Source Charge | Q _{gs} | _ | 1.4 | _ | nC | $V_{DS} = 120V, V_{GS} = 5V$ $I_{D} = 6.5A$ |
| Gate-Drain Charge | Q _{gd} | _ | 3.9 | _ | nC | -1D = 6.3A |
| Turn-On Delay Time (Note 10) | t _{D(on)} | _ | 17.8 | _ | ns | |
| Turn-On Rise Time (Note 10) | t _r | _ | 76.9 | _ | ns | V _{DD} = 100V, V _{GS} = 5V |
| Turn-Off Delay Time (Note 10) | t _{D(off)} | _ | 44.7 | | ns | $I_D = 6.5A, R_G \cong 25\Omega$ |
| Turn-Off Fall Time (Note 10) | t _f | _ | 57.1 | _ | ns | |

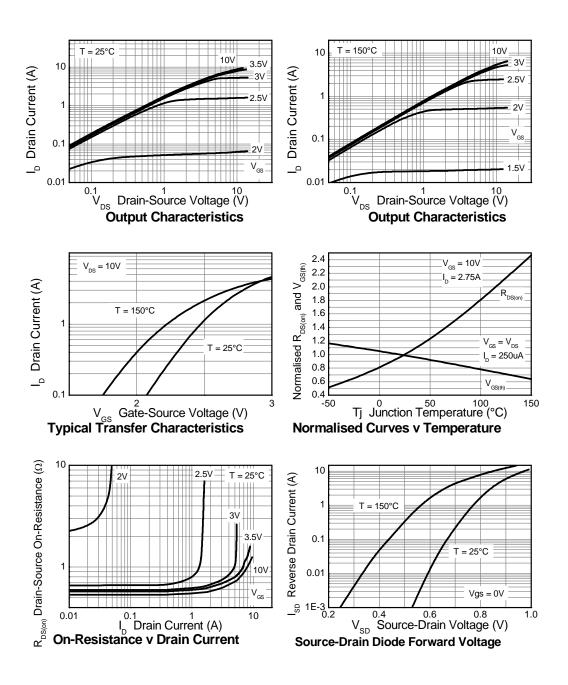
Notes:

- 8. Measured under pulsed conditions. Pulse width ≤ 300µs; duty cycle ≤ 2%
 9. For design aid only, not subject to production testing.
 10. Switching characteristics are independent of operating junction temperatures.



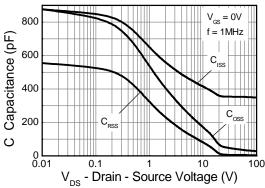


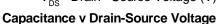
Typical Characteristics

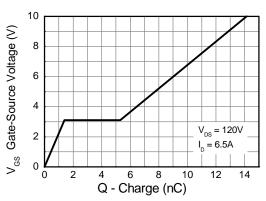




Typical Characteristics - continued

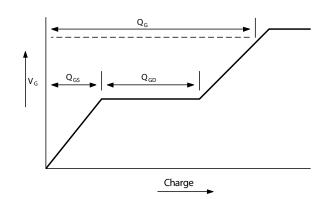




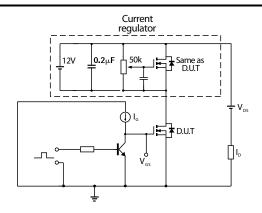


Gate-Source Voltage v Gate Charge

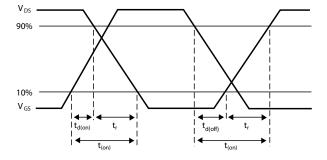
Test Circuits



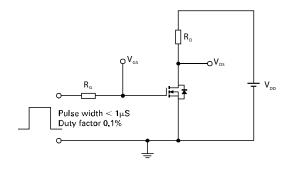
Basic gate charge waveform



Gate charge test circuit

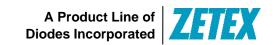


Switching time waveforms

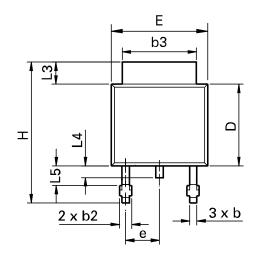


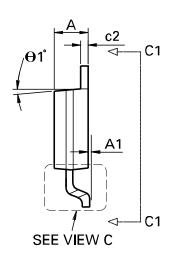
Switching time test circuit

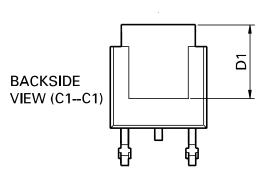


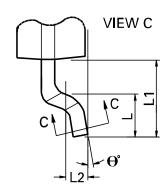


Package Outline Dimensions







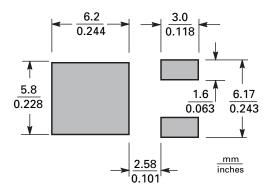


| DIM | Inc | Inches | | Millimeters | | Inches | | Millimeters | |
|------------|-------|--------|-------|-------------|-----|-----------|-------|-------------|-------|
| | Min | Max | Min | Max | | Min | Max | Min | Max |
| Α | 0.086 | 0.094 | 2.18 | 2.39 | е | 0.090 BSC | | 2.29 BSC | |
| A 1 | - | 0.005 | - | 0.127 | Н | 0.370 | 0.410 | 9.40 | 10.41 |
| b | 0.020 | 0.035 | 0.508 | 0.89 | L | 0.055 | 0.070 | 1.40 | 1.78 |
| b2 | 0.030 | 0.045 | 0.762 | 1.14 | L1 | 0.108 REF | | 2.74 REF | |
| b3 | 0.205 | 0.215 | 5.21 | 5.46 | L2 | 0.020 BSC | | 0.508 BSC | |
| С | 0.018 | 0.024 | 0.457 | 0.61 | L3 | 0.035 | 0.065 | 0.89 | 1.65 |
| c2 | 0.018 | 0.023 | 0.457 | 0.584 | L4 | 0.025 | 0.040 | 0.635 | 1.016 |
| D | 0.213 | 0.245 | 5.41 | 6.22 | L5 | 0.045 | 0.060 | 1.14 | 1.52 |
| D1 | 0.205 | - | 5.21 | - | θ1° | 0° | 10° | 0° | 10° |
| Е | 0.250 | 0.265 | 6.35 | 6.73 | θ° | 0° | 15° | 0° | 15° |
| E1 | 0.170 | - | 4.32 | - | - | - | - | - | - |





Suggested Pad Layout



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